

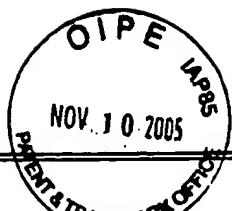


LIST OF PUBLICATIONS CITED BY APPLICANT		<u>Atty. Docket No.</u> SEL 213		<u>Serial No.</u> 09/685,698		
		<u>Applicant</u> Shunpei YAMAZAKI et al				
		<u>Filing Date</u> October 10, 2000		<u>Group</u> 2813		
<b>US PATENT DOCUMENTS</b>						
<b>*EXAMINER INITIAL</b>	<b>DOCUMENT NUMBER</b>	<b>DATE</b>	<b>NAME</b>	<b>CLASS</b>	<b>SUB- CLASS</b>	<b>FILING DATE</b>
<p style="writing-mode: vertical-rl; transform: rotate(180deg);">NOT CONSIDERED</p>	3,484,793	12/16/69	Weigl	347	2	05/02/66
	3,878,517	04/15/75	Kasubuchi et al	346	75	06/01/73
	4,281,332	07/28/81	Horike	346	75	12/26/79
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	JP 07-130652	05/19/95	Semiconductor Energy Lab Co Ltd.	X		10/29/93
	JP 08-078159	03/22/96	Idemitsu Kosan Co.	X		09/08/94
	EP 0 717 446	06/19/96	Eastman Kodak Co.			12/05/95
	JP 08-234683	09/13/96	Eastman Kodak Co.	X		12/12/95
	JP 08-330602	12/13/96	Semiconductor Energy Lab Co Ltd.	X		03/27/96
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**OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS**

(Include name of author (in CAPITAL LETTERS), title of article or item (book, magazine, journal, serial, symposium, catalog, etc.) date, pages(s), volume-issue number(s), publisher, city and/or country where published).

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- 1) WU, C.C. et al, "Integration of Organic LED's and Amorphous Si TFT's Onto Unbreakable Metal Foil Substrates," International Electron Devices Meeting, San Francisco, CA, December 8-11, 1996, IDEM 1996 Technical Digest, pp. 957-959, (1996).
- 2) SHIM, H. et al, "Electrical and Optical Polymer Systems," Donald L. Wise, ed., p. 938, (1998).
- 3) HART, J.A. et al, "A History of Electroluminescent Displays," <http://www.indiana.edu/hightech/fpd/papers/ELDs.html> pp. 1-18 (1999).
- 4) European Search Report re application no. EP 00122446.8, dated June 26, 2001.
- 5) EPO Office Action re application no. EP 00122446.8, dated November 4, 2003.
- 6) European Search Report re application no. EP 00113577.1, dated March 1, 2004.
- 7) European search report re application no. EP 01102402.3, dated April 25, 2005.

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DE 19918193	11/25/99	Cambridge Display Technology Ltd.	X		04/22/90

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(Include name of author (in CAPITAL LETTERS), title of article or item (book, magazine, journal, serial, symposium, catalog, etc.), date, pages(s), volume-issue number(s), publisher, city and/or country where published).

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<i>DS</i>						

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